

Supplementary Material

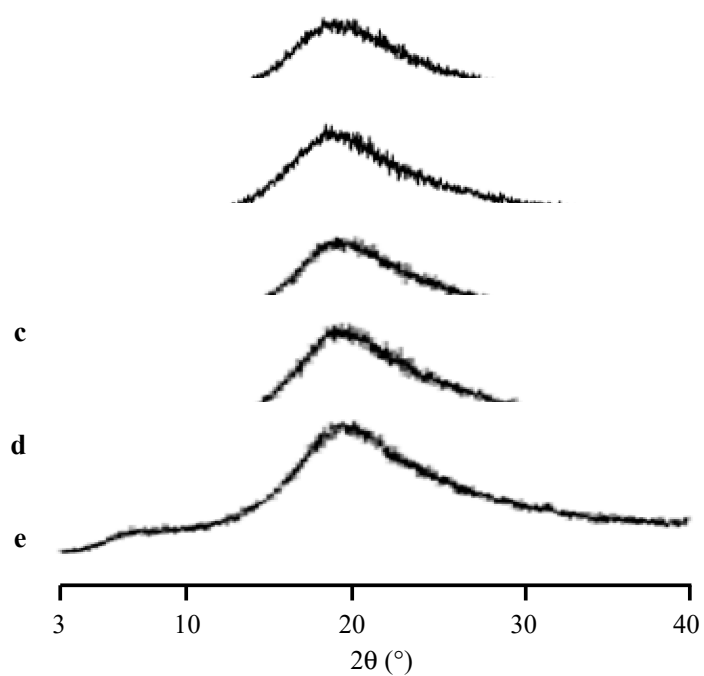


Figure S1. The PXRd patterns of RTV amorphous after (a) 0, (b) 7, (c) 14, (d) 21, and (e) 28 day-storage at 40 °C and 0 % RH.

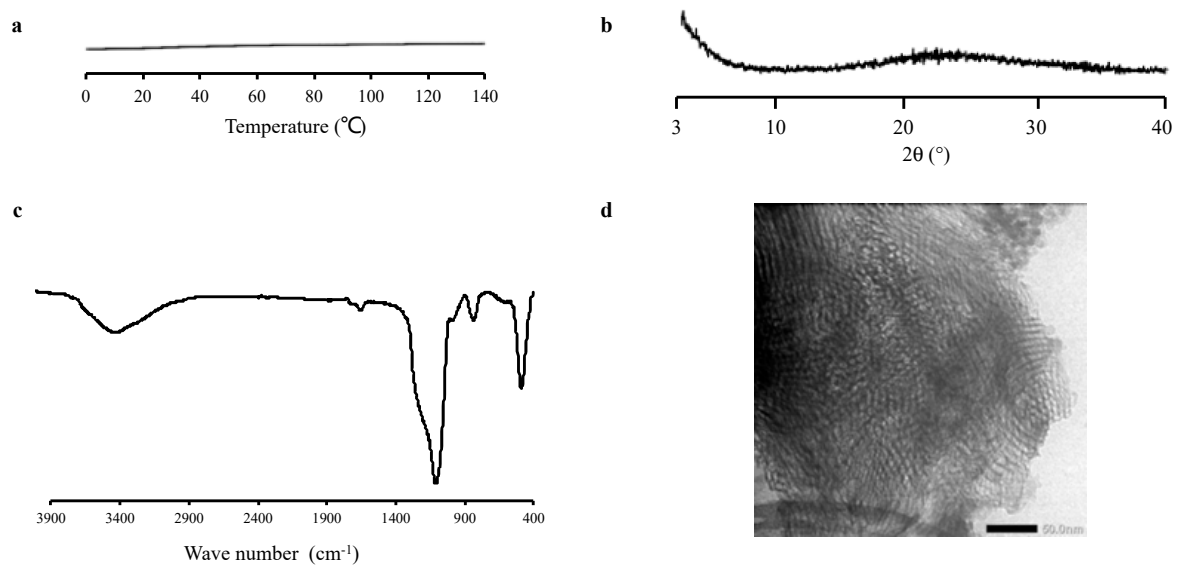


Figure S2. The characterization of MPS after being evaluated by (a) DSC, (b) XRD, (c) FT-IR, and (d) TEM.